Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,876	ZHOU ET AL.	
Examiner	Art Unit	-
Rita Levkin	2837	

SEARCHED					
Class	Subclass	Date	Examiner		
318	439	1/8/2007	R.L.		
	434				
	254				
	138				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
318	439	1/8/2007	R.L.		
	434				
	254				
EA	ST	1/8/2007	R.L.		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
USPAT, DERWENT, EPO, JPO USPGPUB	1/8/2007	R.L.